



# Measurement Science and Technology

## Invitation to Authors

[www.iop.org/journals/mst](http://www.iop.org/journals/mst)

**Submission Deadline**  
**31 December 2006**

### CALL FOR PAPERS

### Special Issue containing papers from OFS-18

*Measurement Science and Technology* invites you to submit a paper to a forthcoming special issue on the 18th International Conference on Optical Fibre Sensors (23rd-27th October 2006) to appear in 2007.

#### Your invitation to submit

*Measurement Science and Technology* is delighted to announce a forthcoming special issue containing papers from the 18th International Conference on Optical Fibre Sensors (23rd-27th October 2006) to be published in 2007, and invites you to submit an article by 31 December 2006.

#### How to submit your paper

- email files as attachments to [mst@iop.org](mailto:mst@iop.org)
- use our submission facility at [www.iop.org/journals/authorsubs](http://www.iop.org/journals/authorsubs)

All submissions should be clearly marked 'OFS-18'.

Papers submitted should not be the copies of those published in the proceedings and can be 8-10 pages in length (approximately 8500 words).

Detailed information on how to submit an article for publication in the journal can be found on our website at <http://authors.iop.org>.

Submissions received after this date will be considered for the journal, but may not be included in the special issue.

#### Refereeing

All submitted articles will be fully refereed to the journal's usual high standards under the supervision of the Guest Editors.

#### Guest Editors

**Ralph P Tatam** Cranfield University, UK

**Julian D C Jones** Heriot-Watt University, UK

#### Editor-in-Chief

**P Hauptmann** Universität Magdeburg, Germany

#### About Measurement Science and Technology

Published 12 times a year, *Measurement Science and Technology* publishes work describing new measurement techniques, significant improvements to existing techniques or the application of existing techniques to a new situation.

Communicating information of great practical and technological relevance to all physicists, chemists, engineers, material scientists, environmental and life scientists, *Measurement Science and Technology* has continued to reinforce its position as an interdisciplinary world-leader.